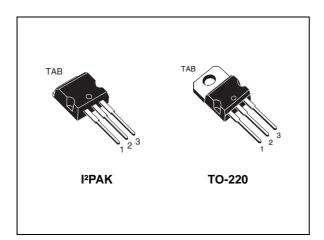


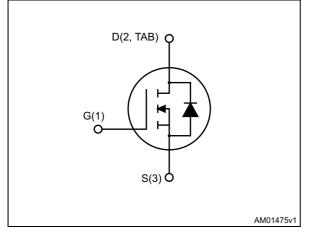
# STI360N4F6, STP360N4F6

Datasheet - production data

Automotive-grade N-channel 40 V, 1.46 mΩ typ., 120 A STripFET<sup>™</sup> F6 Power MOSFETs in I<sup>2</sup>PAK and TO-220 packages



#### Figure 1. Internal schematic diagram



#### Features

Order codes	$V_{DS}$	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STI360N4F6	40 V	1.8 mΩ	120 A
STP360N4F6	40 V	1.0 11122	120 A

- Designed for automotive applications and AEC-Q101 qualified
- Very low on-resistance
- Low gate charge
- High avalanche ruggedness
- Low gate drive power loss

### **Applications**

• Switching applications

### Description

These devices are N-channel Power MOSFETs developed using the STripFET<sup>TM</sup> F6 technology with a new trench gate structure. The resulting Power MOSFETs exhibit very low  $R_{DS(on)}$  in all packages.

#### Table 1. Device summary

Order codes	Marking	Packages	Packing
STI360N4F6	360N4F6	I²PAK	Tube
STP360N4F6	3001141-0	TO-220	Tube

DocID023419 Rev 2

This is information on a product in full production.

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### 1

## Electrical ratings

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage	40	V
V <sub>GS</sub>	Gate-source voltage	±20	V
I <sub>D</sub> <sup>(1)(2)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	120	А
D	Drain current (continuous) at T <sub>C</sub> = 100 °C	120	A
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	480	А
P <sub>TOT</sub>	Total dissipation at $T_{C} = 25 \ ^{\circ}C$	300	W
T <sub>stg</sub>	Storage temperature	- 55 to 175	0°
Тj	Operating junction temperature	- 55 10 175	C

#### Table 2. Absolute maximum ratings

1. Current limited by package.

2. Pulse width is limited by safe operating area.

#### Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	0.5	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max	62.5	0/11



## 2 Electrical characteristics

(T <sub>CASE</sub> = 25 °C unless o	otherwise specified)
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	Table 4. Static					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	40			V
	Zero gate voltage	$V_{GS} = 0 V, V_{DS} = 40 V$			1	μA
I <sub>DSS</sub>	Drain current	$V_{GS} = 0 V, V_{DS} = 40 V, T_{C} = 125 °C$			100	μA
I <sub>GSS</sub>	Gate-body leakage current	$V_{DS} = 0 V, V_{GS} = \pm 0 V$			± 100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	3		4.5	V
R <sub>DS(on)</sub>	Static drain-source on-resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 60 A		1.46	1.8	mΩ

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	17800	-	
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz,	-	1750	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	V <sub>GS</sub> = 0 V	-	1305	-	
Qg	Total gate charge	V <sub>DD</sub> = 20 V, I <sub>D</sub> = 120 A,	-	304	-	
Q <sub>gs</sub>	Gate-source charge	$V_{GS}$ = 10 V (see <i>Figure 14</i> :	-	96	-	nC
Q <sub>gd</sub>	Gate-drain charge	Gate charge test circuit)	-	87	-	

#### Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	$V_{DD} = 20 \text{ V}, I_D = 60 \text{ A}$	-	64	-	
t <sub>r</sub>	Rise time	$R_G = 4.7 \Omega$ , $V_{GS} = 10 V$ (see Figure 13: Switching	-	182	-	
t <sub>d(off)</sub>	Turn-off-delay time	times test circuit for	-	240	-	ns
t <sub>f</sub>	Fall time	resistive load and Figure 18: Switching time waveform)	-	130	-	



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> <sup>(1)</sup>	Source-drain current		-		120	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		480	А
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 120 \text{ A}, V_{GS} = 0 \text{ V}$	-		1.3	V
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 120 \text{ A}, V_{DD} = 32 \text{ V}$	-	44		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt = 100 A/µs,	-	47		nC
I <sub>RRM</sub>	Reverse recovery current	T <sub>j</sub> = 25 °C (see Figure 15: Test circuit for inductive load switching and diode recovery times)	-	2.1		A

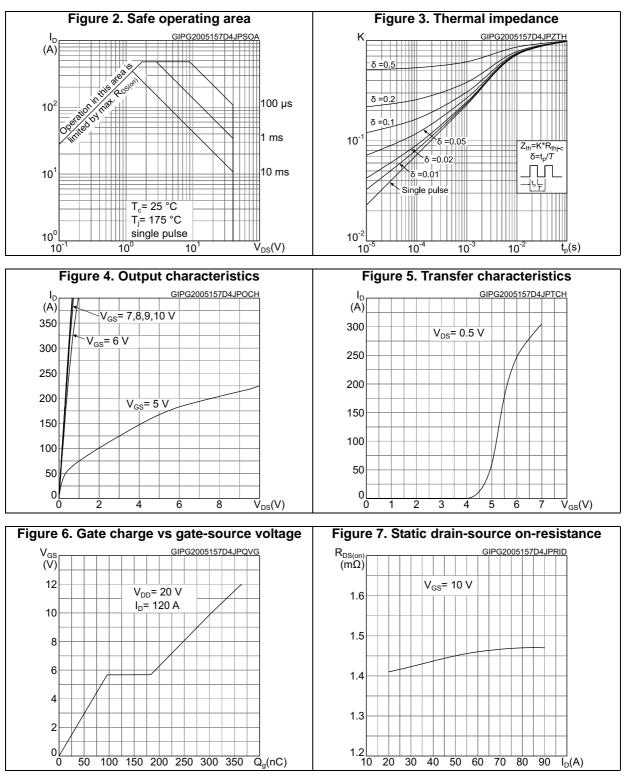
Table 7. Source drain diode	Table	7.	Source	drain	diode
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1. Current limited by package

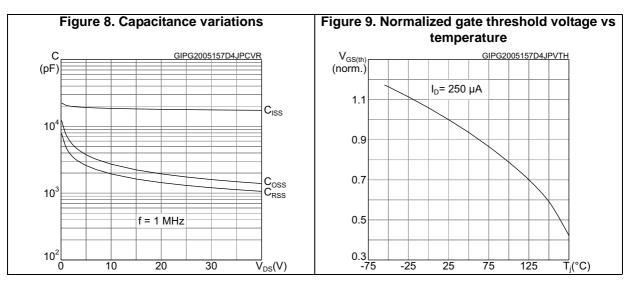
2. Pulsed: pulse duration = 300  $\mu$ s, duty cycle 1.5%

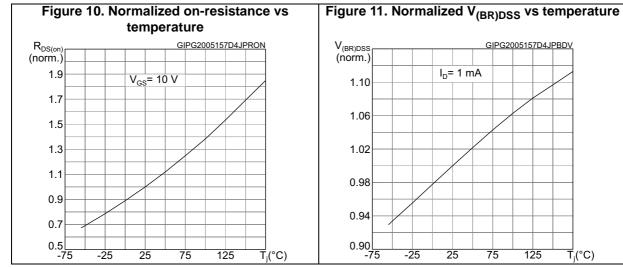


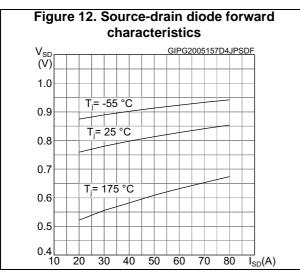
### 2.1 Electrical characteristics (curves)





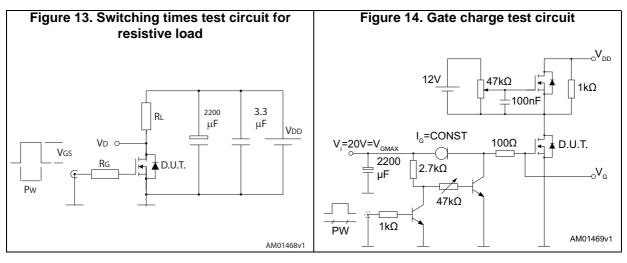


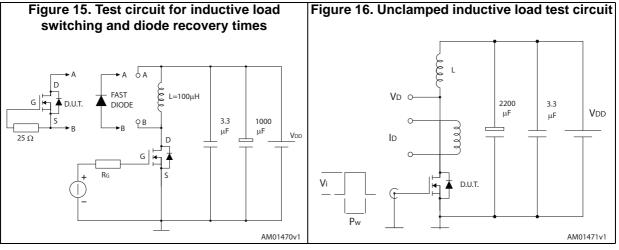


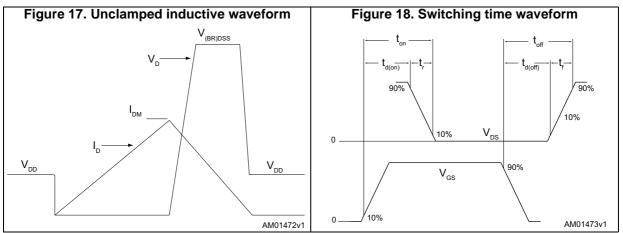




## 3 Test circuits





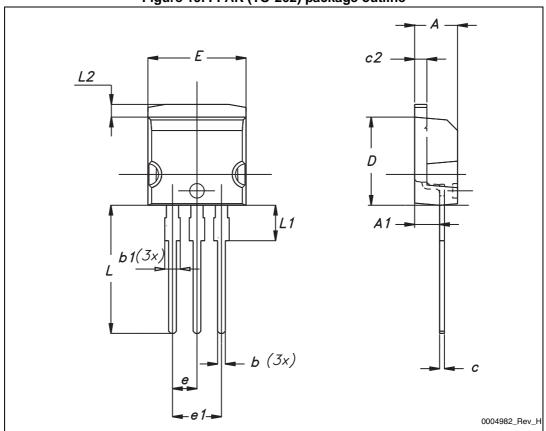




### 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

### 4.1 I<sup>2</sup>PAK package information



#### Figure 19. I<sup>2</sup>PAK (TO-262) package outline



Table 8. IPAK (TO-262) package mechanical data							
DIM.		mm.					
	min.	typ	max.				
А	4.40		4.60				
A1	2.40		2.72				
b	0.61		0.88				
b1	1.14		1.70				
С	0.49		0.70				
c2	1.23		1.32				
D	8.95		9.35				
е	2.40		2.70				
e1	4.95		5.15				
Е	10		10.40				
L	13		14				
L1	3.50		3.93				
L2	1.27		1.40				

Table 8. I<sup>2</sup>PAK (TO-262) package mechanical data



### 4.2 TO-220 package information

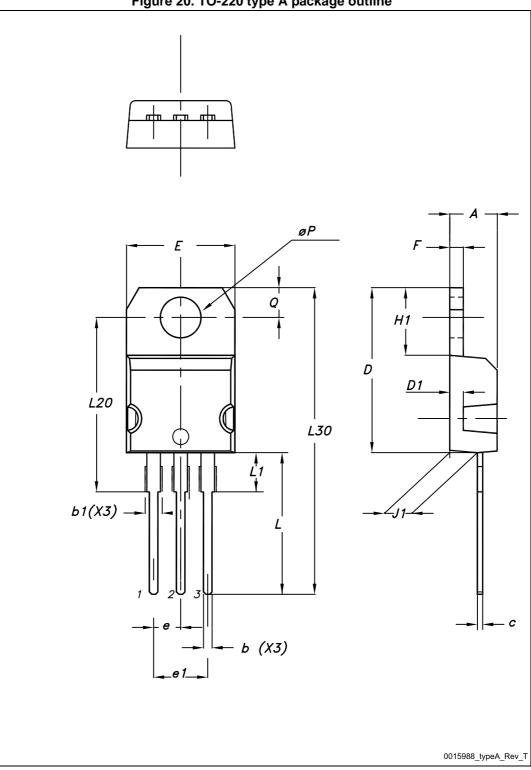


Figure 20. TO-220 type A package outline



Dim. —	mm		
	Min.	Тур.	Max.
А	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

Table 9. TO-220 type A package mechanical data



## 5 Revision history

Date	Revision	Changes	
08-Aug-2012	1	First release.	
03-Dec-2015	2	Text and formatting changes throughout document Updated Section 1: Electrical ratings Updated Section 2: Electrical characteristics Added: Section 2.1: Electrical characteristics (curves) Added: Section 3: Test circuits	

#### Table 10. Document revision history



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